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Sommario/riassunto

This comprehensive guide to gamma-ray spectrometry, authored by Gordon Gilmore and David Joss, provides a detailed exploration of the principles and practices involved in the field. The book covers a wide range of topics, including radioactive decay, interactions of gamma radiation with matter, and the use of semiconductor and scintillation detectors. It also delves into the electronics necessary for gamma-ray spectrometry, statistical methods for data analysis, and calibration techniques. The authors aim to provide both theoretical knowledge and practical insights, making the book suitable for researchers, practitioners, and students in nuclear physics and related disciplines. The third edition includes updated content reflecting advances in technology and methodology, ensuring its relevance to current scientific and industrial applications.
